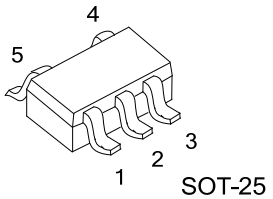
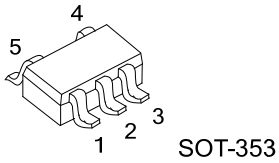
U74AHCT1G86

CMOS IC

2-INPUT EXCLUSIVE-OR GATE



SOT-25



SOT-353

■ DESCRIPTION

The **U74AHCT1G86** is a 2-input EXCLUSIVE-OR gate, it provides the Function Y=A⊕B.

■ FEATURES

* Low Power Current: I_{CC}=1.0μA(Max)
* High Speed: t_{PD}=5ns(Typ)
* High Noise Immunity

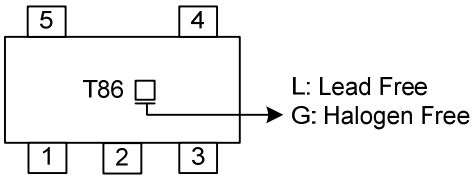
■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74AHCT1G86L-AF5-R	U74AHCT1G86G-AF5-R	SOT-25	Tape Reel
U74AHCT1G86L-AL5-R	U74AHCT1G86G-AL5-R	SOT-353	Tape Reel

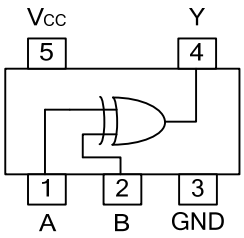
U74AHCT1G86G-AF5-R
(1)Packing Type
(2)Package Type
(3)Green Package

(1) R: Tape Reel
(2) AF5: SOT-25, AL5: SOT-353
(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



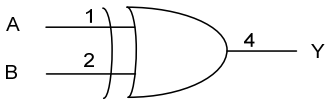
■ PIN CONFIGURATION



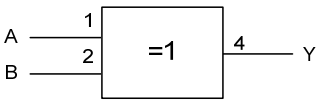
■ FUNCTION TABLE (each gate)

INPUT		OUTPUT
A	B	Y
L	L	L
L	H	H
H	L	H
H	H	L

■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATINGS (Unless otherwise specified) (Note 2)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{CC}	-0.5 ~ 7	V
Input Voltage	V_{IN}	-0.5 ~ 7	V
Output Voltage	V_{OUT}	-0.5 ~ V_{CC}+0.5	V
Input Clamp Current	I_{IK}	-20	mA
Output Clamp Current	I_{OK}	±20	mA
Output Current	I_{OUT}	±25	mA
V_{CC} or GND Current	I_{CC}	±50	mA
Storage Temperature	T_{STG}	-65 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

■ RECOMMENDED OPERATING CONDITIONS (Unless otherwise specified)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}		4.5		5.5	V
Input Voltage	V_{IN}		0		5.5	V
Output Voltage	V_{OUT}		0		V_{CC}	V
Input Transition Rise or Fall Rate	Δt/Δv	V_{CC}=5.0+0.5V			20	ns/V
Operating Temperature	T_A		-40		+125	°C

■ STATIC CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V_{IH}	V_{CC}=4.5V~5.5V	2.0			V
Low-Level Input Voltage	V_{IL}	V_{CC}=4.5V~5.5V			0.8	V
High-Level Output Voltage	V_{OH}	V_{CC}=4.5V, I_{OH}=-50μA	4.4	4.5		V
		V_{CC}=4.5V, I_{OH}=-8mA	3.94			
Low-Level Output Voltage	V_{OL}	V_{CC}=4.5V, I_{OL}=50μA			0.1	V
		V_{CC}=4.5V, I_{OL}=8mA			0.36	
Input Leakage Current	$I_{I(LEAK)}$	V_{CC}=5.5V, V_{IN}=V_{CC} or GND			±0.1	μA
Quiescent Supply Current	I_Q	V_{CC}=5.5V, V_{IN}=V_{CC} or GND I_{OUT}=0			1	μA
Additional Quiescent Supply Current	Δ I_Q	V_{CC}=5.5V, V_{IN}=3.4V; I_{OUT}=0; other input at V_{CC} or GND			1.35	mA
Input Capacitance	C_{IN}	V_{IN}=V_{CC} or GND		4	10	pF

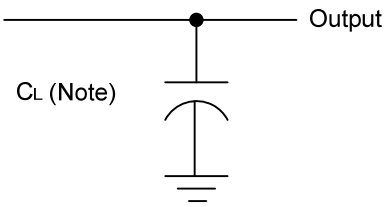
■ DYNAMIC CHARACTERISTICS (t_R, t_F≤3ns; PRR≤1MHz, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from input (A or B) to output(Y)	t_{PLH}	V_{CC}=5±0.5V, C_L=15pF		5	6.9	ns
	t_{PHL}			5	6.9	
	t_{PLH}	V_{CC}=5±0.5V, C_L=50pF		5.5	7.9	
	t_{PHL}			5.5	7.9	

■ OPERATING CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	V_{CC}=5V, f=1MHz, No load		18		pF

■ TEST CIRCUIT AND WAVEFORMS



Note: C_L includes probe and jig capacitance.